What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "Embedded - Microcontrollers"

Details	
Product Status	Obsolete
Core Processor	XCore
Core Size	32-Bit 12-Core
Speed	2000MIPS
Connectivity	USB
Peripherals	-
Number of I/O	81
Program Memory Size	2MB (2M x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	512K x 8
Voltage - Supply (Vcc/Vdd)	0.95V ~ 3.6V
Data Converters	-
Oscillator Type	External
Operating Temperature	0°C ~ 70°C (TA)
Mounting Type	Surface Mount
Package / Case	128-TQFP Exposed Pad
Supplier Device Package	128-TQFP (14x14)
Purchase URL	https://www.e-xfl.com/product-detail/xmos/xuf212-512-tq128-c20

Table of Contents

- **Ports** The I/O pins are connected to the processing cores by Hardware Response ports. The port logic can drive its pins high and low, or it can sample the value on its pins optionally waiting for a particular condition. Section 6.3
- **Clock blocks** xCORE devices include a set of programmable clock blocks that can be used to govern the rate at which ports execute. Section 6.4
- **Memory** Each xCORE Tile integrates a bank of SRAM for instructions and data, and a block of one-time programmable (OTP) memory that can be configured for system wide security features. Section 9
- **PLL** The PLL is used to create a high-speed processor clock given a low speed external oscillator. Section 7
- **USB** The USB PHY provides High-Speed and Full-Speed, device, host, and on-the-go functionality. Data is communicated through ports on the digital node. A library is provided to implement USB device functionality. Section 10
- **Flash** The device has a built-in 2MBflash. Section 8
- **JTAG** The JTAG module can be used for loading programs, boundary scan testing, in-circuit source-level debugging and programming the OTP memory. Section 11

1.1 Software

Devices are programmed using C, C++ or xC (C with multicore extensions). XMOS provides tested and proven software libraries, which allow you to quickly add interface and processor functionality such as USB, Ethernet, PWM, graphics driver, and audio EQ to your applications.

1.2 xTIMEcomposer Studio

The xTIMEcomposer Studio development environment provides all the tools you need to write and debug your programs, profile your application, and write images into flash memory or OTP memory on the device. Because xCORE devices operate deterministically, they can be simulated like hardware within xTIMEcomposer: uniquely in the embedded world, xTIMEcomposer Studio therefore includes a static timing analyzer, cycle-accurate simulator, and high-speed in-circuit instrumentation.

xTIMEcomposer can be driven from either a graphical development environment, or the command line. The tools are supported on Windows, Linux and MacOS X and available at no cost from xmos.com/downloads. Information on using the tools is provided in the xTIMEcomposer User Guide, X3766.

2 XUF212-512-TQ128 Features

- **Multicore Microcontroller with Advanced Multi-Core RISC Architecture**
  - 12 real-time logical cores on 2 xCORE tiles
  - Cores share up to 1000 MIPS
    - Up to 2000 MIPS in dual issue mode
  - Each logical core has:
    - Guaranteed throughput of between 1/5 and 1/6 of tile MIPS
    - 16x32bit dedicated registers
  - 167 high-density 16/32-bit instructions
    - All have single clock-cycle execution (except for divide)
    - 32x32→64-bit MAC instructions for DSP, arithmetic and user-definable cryptographic functions
- **USB PHY, fully compliant with USB 2.0 specification**
- **Programmable I/O**
  - 81 general-purpose I/O pins, configurable as input or output
    - Up to 25 x 1bit port, 12 x 4bit port, 8 x 8bit port, 4 x 16bit port
    - 4 xCONNECT links
  - Port sampling rates of up to 60 MHz with respect to an external clock
  - 64 channel endss (32 per tile) for communication with other cores, on or off-chip
- **Memory**
  - 512KB internal single-cycle SRAM (max 256KB per tile) for code and data storage
  - 16KB internal OTP (max 8KB per tile) for application boot code
  - 2MB internal flash for application code and overlays
- **Hardware resources**
  - 12 clock blocks (6 per tile)
  - 20 timers (10 per tile)
  - 8 locks (4 per tile)
- **JTAG Module for On-Chip Debug**
- **Security Features**
  - Programming lock disables debug and prevents read-back of memory contents
  - AES bootloader ensures secrecy of IP held on external flash memory
- **Ambient Temperature Range**
  - Commercial qualification: 0 °C to 70 °C
  - Industrial qualification: -40 °C to 85 °C
- **Speed Grade**
  - 20: 1000 MIPS
- **Power Consumption**
  - 570 mA (typical)
- **128-pin TQFP package 0.4 mm pitch**

4 Signal Description

This section lists the signals and I/O pins available on the XUF212-512-TQ128. The device provides a combination of 1bit, 4bit, 8bit and 16bit ports, as well as wider ports that are fully or partially (gray) bonded out. All pins of a port provide either output or input, but signals in different directions cannot be mapped onto the same port.

Pins may have one or more of the following properties:

- PD/PU: The IO pin has a weak pull-down or pull-up resistor. The resistor is enabled during and after reset. Enabling a link or port that uses the pin disables the resistor. Thereafter, the resistor can be enabled or disabled under software control. The resistor is designed to ensure defined logic input state for unconnected pins. It should not be used to pull external circuitry. Note that the resistors are highly non-linear and only a maximum pull current is specified in Section 13.2.
- ST: The IO pin has a Schmitt Trigger on its input.
- IOL/IOT/IOR: The IO pin is powered from VDDIOL, VDDIOT, and VDDIOR respectively

Power pins (10)			
Signal	**Function**	**Type**	**Properties**
GND	Digital ground	GND	
OTP_VCC	OTP power supply	PWR	
PLL_AGND	Analog ground for PLL	PWR	
PLL_AVDD	Analog PLL power	PWR	
USB_VDD	Digital tile power	PWR	
USB_VDD33	USB Analog power	PWR	
VDD	Digital tile power	PWR	
VDDIOL	Digital I/O power (left)	PWR	
VDDIOR	Digital I/O power (right)	PWR	
VDDIOT	Digital I/O power (top)	PWR	

JTAG pins (6)			
Signal	**Function**	**Type**	**Properties**
RST_N	Global reset input	Input	IOL, PU, ST
TCK	Test clock	Input	IOL, PD, ST
TDI	Test data input	Input	IOL, PU
TDO	Test data output	Output	IOL, PD
TMS	Test mode select	Input	IOL, PU
TRST_N	Test reset input	Input	IOL, PU, ST

Signal	Function						Type	Properties
X0D41	$X_0L0^0_{in}$			$8D^5$	$16B^{13}$		I/O	IOL, PD
X0D42	$X_0L0^0_{out}$			$8D^6$	$16B^{14}$		I/O	IOL, PD
X0D43	$X_0L0^1_{out}$			$8D^7$	$16B^{15}$		I/O	IOL, PD
X1D00	$X_0L7^2_{in}$	$1A^0$					I/O	IOR, PD
X1D01	$X_0L7^1_{in}$	$1B^0$					I/O	IOR, PD
X1D02	$X_0L4^0_{in}$		$4A^0$	$8A^0$	$16A^0$	$32A^{20}$	I/O	IOR, PD
X1D03	$X_0L4^0_{out}$		$4A^1$	$8A^1$	$16A^1$	$32A^{21}$	I/O	IOR, PD
X1D04	$X_0L4^1_{out}$		$4B^0$	$8A^2$	$16A^2$	$32A^{22}$	I/O	IOR, PD
X1D05	$X_0L4^2_{out}$		$4B^1$	$8A^3$	$16A^3$	$32A^{23}$	I/O	IOR, PD
X1D06	$X_0L4^3_{out}$		$4B^2$	$8A^4$	$16A^4$	$32A^{24}$	I/O	IOR, PD
X1D07	$X_0L4^4_{out}$		$4B^3$	$8A^5$	$16A^5$	$32A^{25}$	I/O	IOR, PD
X1D08	$X_0L7^4_{in}$		$4A^2$	$8A^6$	$16A^6$	$32A^{26}$	I/O	IOR, PD
X1D09	$X_0L7^3_{in}$		$4A^3$	$8A^7$	$16A^7$	$32A^{27}$	I/O	IOR, PD
X1D10		$1C^0$					I/O	IOT, PD
X1D11		$1D^0$					I/O	IOT, PD
X1D14			$4C^0$	$8B^0$	$16A^8$	$32A^{28}$	I/O	IOR, PD
X1D15			$4C^1$	$8B^1$	$16A^9$	$32A^{29}$	I/O	IOR, PD
X1D16	$X_0L3^1_{in}$		$4D^0$	$8B^2$	$16A^{10}$		I/O	IOL, PD
X1D17	$X_0L3^0_{in}$		$4D^1$	$8B^3$	$16A^{11}$		I/O	IOL, PD
X1D18	$X_0L3^0_{out}$		$4D^2$	$8B^4$	$16A^{12}$		I/O	IOL, PD
X1D19	$X_0L3^1_{out}$		$4D^3$	$8B^5$	$16A^{13}$		I/O	IOL, PD
X1D20			$4C^2$	$8B^6$	$16A^{14}$	$32A^{30}$	I/O	IOR, PD
X1D21			$4C^3$	$8B^7$	$16A^{15}$	$32A^{31}$	I/O	IOR, PD
X1D26			$4E^0$	$8C^0$	$16B^0$		I/O	IOT, PD
X1D27			$4E^1$	$8C^1$	$16B^1$		I/O	IOT, PD
X1D28			$4F^0$	$8C^2$	$16B^2$		I/O	IOT, PD
X1D29			$4F^1$	$8C^3$	$16B^3$		I/O	IOT, PD
X1D30			$4F^2$	$8C^4$	$16B^4$		I/O	IOT, PD
X1D31			$4F^3$	$8C^5$	$16B^5$		I/O	IOT, PD
X1D32			$4E^2$	$8C^6$	$16B^6$		I/O	IOT, PD
X1D33			$4E^3$	$8C^7$	$16B^7$		I/O	IOT, PD
X1D35		$1L^0$					I/O	IOL, PD
X1D36		$1M^0$		$8D^0$	$16B^8$		I/O	IOL, PD
X1D37		$1N^0$		$8D^1$	$16B^9$		I/O	IOL, PD
X1D38		$1O^0$		$8D^2$	$16B^{10}$		I/O	IOL, PD
X1D39		$1P^0$		$8D^3$	$16B^{11}$		I/O	IOL, PD
X1D40				$8D^4$	$16B^{12}$		I/O	IOT, PD
X1D41				$8D^5$	$16B^{13}$		I/O	IOT, PD
X1D42				$8D^6$	$16B^{14}$		I/O	IOT, PD
X1D43				$8D^7$	$16B^{15}$		I/O	IOT, PD

5 Example Application Diagram

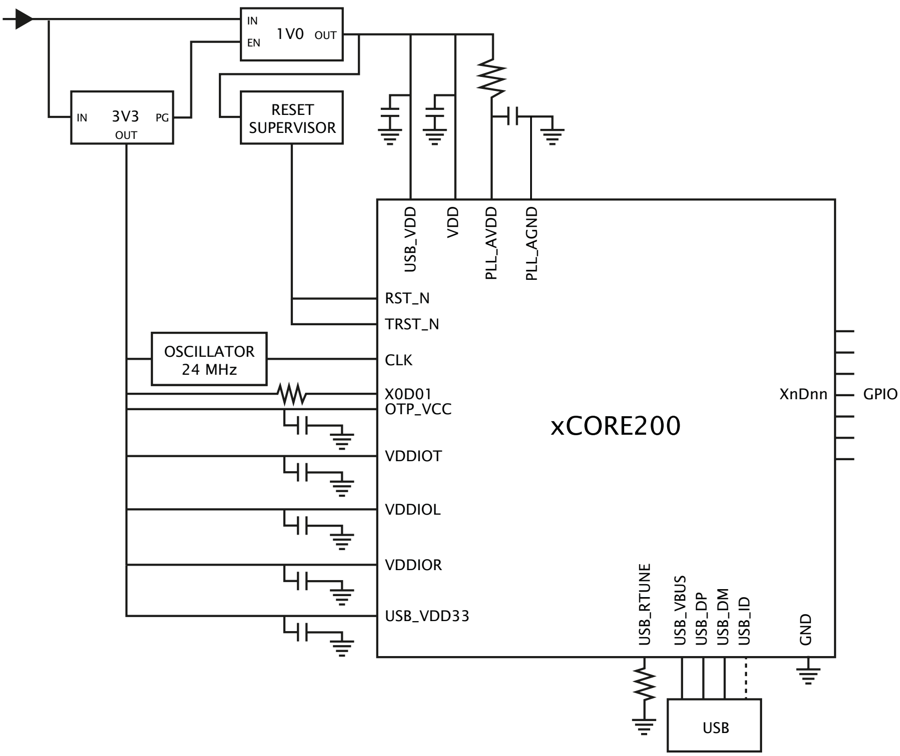


Figure 2: Simplified Reference Schematic

- see Section 10 for details on the USB PHY
- see Section 12 for details on the power supplies and PCB design

The JTAG usercode register can be read by using the USERCODE instruction. Its contents are specified in Figure 15. The OTP User ID field is read from bits [22:31] of the security register on xCORE Tile 0, *see* §9.1 (all zero on unprogrammed devices).

Figure 15: USERCODE return value

<table>
<tr><td colspan="4">Bit31</td><td colspan="24">Usercode Register</td><td colspan="4">Bit0</td></tr>
<tr><td colspan="10">OTP User ID</td><td colspan="4">Unused</td><td colspan="18">Silicon Revision</td></tr>
<tr><td>0</td><td>0</td><td>0</td><td>0</td><td>0</td><td>0</td><td>0</td><td>0</td><td>0</td><td>0</td><td>0</td><td>0</td><td>0</td><td>0</td><td>1</td><td>0</td><td>1</td><td>0</td><td>0</td><td>0</td><td>0</td><td>0</td><td>0</td><td>0</td><td>0</td><td>0</td><td>0</td><td>0</td><td>0</td><td>0</td><td>0</td><td>0</td></tr>
<tr><td colspan="4">0</td><td colspan="4">0</td><td colspan="4">0</td><td colspan="4">2</td><td colspan="4">8</td><td colspan="4">0</td><td colspan="4">0</td><td colspan="4">0</td></tr>
</table>

12 Board Integration

The device has the following power supply pins:

- VDD pins for the xCORE Tile, including a USB_VDD pin that powers the USB PHY
- VDDIO pins for the I/O lines. Separate I/O supplies are provided for the left, top, and right side of the package; different I/O voltages may be supplied on those. The signal description (Section 4) specifies which I/O is powered from which power-supply
- PLL_AVDD pins for the PLL
- OTP_VCC pins for the OTP
- A USB_VDD33 pin for the analogue supply to the USB-PHY

Several pins of each type are provided to minimize the effect of inductance within the package, all of which must be connected. The power supplies must be brought up monotonically and input voltages must not exceed specification at any time.

The VDD supply must ramp from 0 V to its final value within 10 ms to ensure correct startup.

The VDDIO and OTP_VCC supply must ramp to its final value before VDD reaches 0.4 V.

The PLL_AVDD supply should be separated from the other noisier supplies on the board. The PLL requires a very clean power supply, and a low pass filter (for example, a 4.7 Ω resistor and 100 nF multi-layer ceramic capacitor) is recommended on this pin.

The following ground pins are provided:

- PLL_AGND for PLL_AVDD
- GND for all other supplies

All ground pins must be connected directly to the board ground.

The VDD and VDDIO supplies should be decoupled close to the chip by several 100 nF low inductance multi-layer ceramic capacitors between the supplies and GND (for example, 100nF 0402 for each supply pin). The ground side of the decoupling capacitors should have as short a path back to the GND pins as possible. A bulk decoupling capacitor of at least 10 uF should be placed on each of these supplies.

RST_N is an active-low asynchronous-assertion global reset signal. Following a reset, the PLL re-establishes lock after which the device boots up according to the boot mode (*see* §8). RST_N and must be asserted low during and after power up for 100 ns.

12.1 USB connections

USB_VBUS should be connected to the VBUS pin of the USB connector. A 2.2 uF capacitor to ground is required on the VBUS pin. A ferrite bead may be used to reduce HF noise.

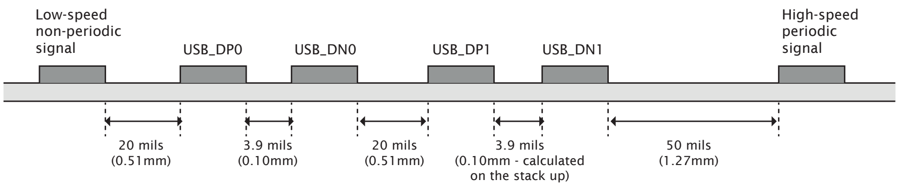
For self-powered systems, a bleeder resistor may be required to stop VBUS from floating when no USB cable is attached.

USB_DP and USB_DN should be connected to the USB connector. USB_ID does not need to be connected.

12.2 USB signal routing and placement

The USB_DP and USB_DN lines are the positive and negative data polarities of a high speed USB signal respectively. Their high-speed differential nature implies that they must be coupled and properly isolated. The board design must ensure that the board traces for USB_DP and USB_DN are tightly matched. In addition, according to the USB 2.0 specification, the USB_DP and USB_DN differential impedance must be 90 Ω.

Figure 16: USB trace separation showing a low speed signal, two differential pairs and a high-speed clock



12.2.1 General routing and placement guidelines

The following guidelines will help to avoid signal quality and EMI problems on high speed USB designs. They relate to a four-layer (Signal, GND, Power, Signal) PCB.

For best results, most of the routing should be done on the top layer (assuming the USB connector and XS2-UF12A-512-TQ128 are on the top layer) closest to

13.5 Power Consumption

Symbol	Parameter	MIN	TYP	MAX	UNITS	Notes
I(DDCQ)	Quiescent VDD current		45		mA	A, B, C
PD	Tile power dissipation		325		μW/MIPS	A, D, E, F
IDD	Active VDD current		570	700	mA	A, G
I(ADDPLL)	PLL_AVDD current		5	7	mA	H
I(VDD33)	VDD33 current		26.7		mA	I
I(USB_VDD)	USB_VDD current		8.27		mA	J

Figure 23: xCORE Tile currents

A Use for budgetary purposes only.
B Assumes typical tile and I/O voltages with no switching activity.
C Includes PLL current.
D Assumes typical tile and I/O voltages with nominal switching activity.
E Assumes 1 MHz = 1 MIPS.
F PD(TYP) value is the usage power consumption under typical operating conditions.
G Measurement conditions: VDD = 1.0 V, VDDIO = 3.3 V, 25 °C, 500 MHz, average device resource usage.
H PLL_AVDD = 1.0 V
I HS mode transmitting while driving all 0's data (constant JKJK on DP/DM). Loading of 10 pF. Transfers do not include any interpacket delay.
J HS receive mode; no traffic.

The tile power consumption of the device is highly application dependent and should be used for budgetary purposes only.

More detailed power analysis can be found in the XS1-UF Power Consumption document,

13.6 Clock

Symbol	Parameter	MIN	TYP	MAX	UNITS	Notes
f	Frequency	9	24	25	MHz	
SR	Slew rate	0.10			V/ns	
TJ(LT)	Long term jitter (pk-pk)			2	%	A
f(MAX)	Processor clock frequency			500	MHz	B

Figure 24: Clock

A Percentage of CLK period.
B Assumes typical tile and I/O voltages with nominal activity.

Further details can be found in the XS1-UF Clock Frequency Control document,

14.1 Part Marking

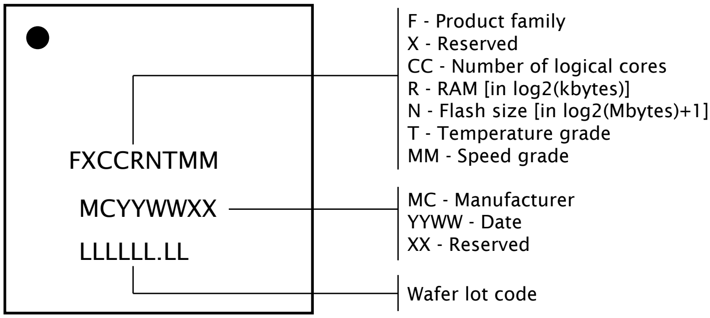


Figure 28: Part marking scheme

15 Ordering Information

Figure 29: Orderable part numbers

Product Code	Marking	Qualification	Speed Grade
XUF212-512-TQ128-C20	U11292C20	Commercial	1000 MIPS
XUF212-512-TQ128-I20	U11292I20	Industrial	1000 MIPS

0x12: Debug SSP

Bits	Perm	Init	Description
31:0	DRW		Value.

B.15 DGETREG operand 1: 0x13

The resource ID of the logical core whose state is to be read.

0x13: DGETREG operand 1

Bits	Perm	Init	Description
31:8	RO	-	Reserved
7:0	DRW		Thread number to be read

B.16 DGETREG operand 2: 0x14

Register number to be read by DGETREG

0x14: DGETREG operand 2

Bits	Perm	Init	Description
31:5	RO	-	Reserved
4:0	DRW		Register number to be read

B.17 Debug interrupt type: 0x15

Register that specifies what activated the debug interrupt.

0x15: Debug interrupt type

Bits	Perm	Init	Description
31:18	RO	-	Reserved
17:16	DRW		Number of the hardware breakpoint/watchpoint which caused the interrupt (always 0 for =HOST= and =DCALL=). If multiple breakpoints/watchpoints trigger at once, the lowest number is taken.
15:8	DRW		Number of thread which caused the debug interrupt (always 0 in the case of =HOST=).
7:3	RO	-	Reserved
2:0	DRW	0	Indicates the cause of the debug interrupt 1: Host initiated a debug interrupt through JTAG 2: Program executed a DCALL instruction 3: Instruction breakpoint 4: Data watch point 5: Resource watch point

B.25 Data breakpoint control register: 0x70 .. 0x73

This set of registers controls each of the four data watchpoints.

0x70 .. 0x73: Data breakpoint control register

Bits	Perm	Init	Description
31:24	RO	-	Reserved
23:16	DRW	0	A bit for each thread in the machine allowing the breakpoint to be enabled individually for each thread.
15:3	RO	-	Reserved
2	DRW	0	When 1 the breakpoints will be be triggered on loads.
1	DRW	0	Determines the break condition: 0 = A AND B, 1 = A OR B.
0	DRW	0	When 1 the instruction breakpoint is enabled.

B.26 Resources breakpoint mask: 0x80 .. 0x83

This set of registers contains the mask for the four resource watchpoints.

0x80 .. 0x83: Resources breakpoint mask

Bits	Perm	Init	Description
31:0	DRW		Value.

B.27 Resources breakpoint value: 0x90 .. 0x93

This set of registers contains the value for the four resource watchpoints.

0x90 .. 0x93: Resources breakpoint value

Bits	Perm	Init	Description
31:0	DRW		Value.

B.28 Resources breakpoint control register: 0x9C .. 0x9F

This set of registers controls each of the four resource watchpoints.

0x62: SR of logical core 2

Bits	Perm	Init	Description
31:0	CRO		Value.

C.20 SR of logical core 3: 0x63

Value of the SR of logical core 3

0x63: SR of logical core 3

Bits	Perm	Init	Description
31:0	CRO		Value.

C.21 SR of logical core 4: 0x64

Value of the SR of logical core 4

0x64: SR of logical core 4

Bits	Perm	Init	Description
31:0	CRO		Value.

C.22 SR of logical core 5: 0x65

Value of the SR of logical core 5

0x65: SR of logical core 5

Bits	Perm	Init	Description
31:0	CRO		Value.

C.23 SR of logical core 6: 0x66

Value of the SR of logical core 6

0x66: SR of logical core 6

Bits	Perm	Init	Description
31:0	CRO		Value.

C.24 SR of logical core 7: 0x67

Value of the SR of logical core 7

0x67:
SR of logical core 7

Bits	Perm	Init	Description
31:0	CRO		Value.

D Node Configuration

The digital node control registers can be accessed using configuration reads and writes (use `write_node_config_reg(device, ...)` and `read_node_config_reg(device, ↪ ...)` for reads and writes).

Number	Perm	Description
0x00	RO	Device identification
0x01	RO	System switch description
0x04	RW	Switch configuration
0x05	RW	Switch node identifier
0x06	RW	PLL settings
0x07	RW	System switch clock divider
0x08	RW	Reference clock
0x09	R	System JTAG device ID register
0x0A	R	System USERCODE register
0x0C	RW	Directions 0-7
0x0D	RW	Directions 8-15
0x10	RW	Reserved
0x11	RW	Reserved.
0x1F	RO	Debug source
0x20 .. 0x28	RW	Link status, direction, and network
0x40 .. 0x47	RO	PLink status and network
0x80 .. 0x88	RW	Link configuration and initialization
0xA0 .. 0xA7	RW	Static link configuration

Figure 33: Summary

D.1 Device identification: 0x00

This register contains version and revision identifiers and the mode-pins as sampled at boot-time.

Bits	Perm	Init	Description
31:24	RO	-	Reserved
23:16	RO		Sampled values of BootCtl pins on Power On Reset.
15:8	RO		SSwitch revision.
7:0	RO		SSwitch version.

0x00: Device identification

E.3 Node identifier: 0x05

0x05: Node identifier

Bits	Perm	Init	Description
31:16	RO	-	Reserved
15:0	RW	0	16-bit node identifier. This does not need to be set, and is present for compatibility with XS1-switches.

E.4 System clock frequency: 0x51

0x51: System clock frequency

Bits	Perm	Init	Description
31:7	RO	-	Reserved
6:0	RW	25	Oscillator clock frequency in MHz rounded up to the nearest integer value. Only values between 5 and 100 MHz are valid - writes outside this range are ignored and will be NACKed. This field must be set on start up of the device and any time that the input oscillator clock frequency is changed. It must contain the system clock frequency in MHz rounded up to the nearest integer value.

E.5 Link Control and Status: 0x80

0x80: Link Control and Status

Bits	Perm	Init	Description
31:28	RO	-	Reserved
27	RO		Rx buffer overflow or illegal token encoding received.
26	RO	0	This end of the xlink has issued credit to allow the remote end to transmit
25	RO	0	This end of the xlink has credit to allow it to transmit.
24	WO		Clear this end of the xlink's credit and issue a HELLO token.
23	WO		Reset the receiver. The next symbol that is detected will be the first symbol in a token.
22	RO	-	Reserved
21:11	RW	1	Specify min. number of idle system clocks between two continuous symbols witin a transmit token -1.
10:0	RW	1	Specify min. number of idle system clocks between two continuous transmit tokens -1.

0x10: UIFM on-the-go control

Bits	Perm	Init	Description
31:8	RO	-	Reserved
7	RW	0	Set to 1 to switch UIFM to EXTVBUSIND mode.
6	RW	0	Set to 1 to switch UIFM to DRVVBUSEXT mode.
5	RO	-	Reserved
4	RW	0	Set to 1 to switch UIFM to UTMI+ CHRGVBUS mode.
3	RW	0	Set to 1 to switch UIFM to UTMI+ DISCHRGVBUS mode.
2	RW	0	Set to 1 to switch UIFM to UTMI+ DMPULLDOWN mode.
1	RW	0	Set to 1 to switch UIFM to UTMI+ DPPULLDOWN mode.
0	RW	0	Set to 1 to switch UIFM to IDPULLUP mode.

F.6 UIFM on-the-go flags: 0x14

Status flags used for on-the-go negotiation

0x14: UIFM on-the-go flags

Bits	Perm	Init	Description
31:6	RO	-	Reserved
5	RO	0	Value of UTMI+ Bvalid flag.
4	RO	0	Value of UTMI+ IDGND flag.
3	RO	0	Value of UTMI+ HOSTDIS flag.
2	RO	0	Value of UTMI+ VBUSVLD flag.
1	RO	0	Value of UTMI+ SESSVLD flag.
0	RO	0	Value of UTMI+ SESSEND flag.

F.7 UIFM Serial Control: 0x18

0x18: UIFM Serial Control

Bits	Perm	Init	Description
31:7	RO	-	Reserved
6	RO	0	1 if UIFM is in UTMI+ RXRCV mode.
5	RO	0	1 if UIFM is in UTMI+ RXDM mode.
4	RO	0	1 if UIFM is in UTMI+ RXDP mode.
3	RW	0	Set to 1 to switch UIFM to UTMI+ TXSE0 mode.
2	RW	0	Set to 1 to switch UIFM to UTMI+ TXDATA mode.
1	RW	1	Set to 0 to switch UIFM to UTMI+ TXENABLE mode.
0	RW	0	Set to 1 to switch UIFM to UTMI+ FSLSSERIAL mode.

F.8 UIFM signal flags: 0x1C

Set of flags that monitor line and error states. These flags normally clear on the next packet, but they may be made sticky by using PER_UIFM_FLAGS_STICKY, in which they must be cleared explicitly.

0x1C: UIFM signal flags

Bits	Perm	Init	Description
31:7	RO	-	Reserved
6	RW	0	Set to 1 when the UIFM decodes a token successfully (e.g. it passes CRC5, PID check and has matching device address).
5	RW	0	Set to 1 when linestate indicates an SE0 symbol.
4	RW	0	Set to 1 when linestate indicates a K symbol.
3	RW	0	Set to 1 when linestate indicates a J symbol.
2	RW	0	Set to 1 if an incoming datapacket fails the CRC16 check.
1	RW	0	Set to the value of the UTMI_RXACTIVE input signal.
0	RW	0	Set to the value of the UTMI_RXERROR input signal

F.9 UIFM Sticky flags: 0x20

These bits define the sticky-ness of the bits in the UIFM IFM FLAGS register. A 1 means that bit will be sticky (hold its value until a 1 is written to that bitfield), or normal, in which case signal updates to the UIFM IFM FLAGS bits may be over-written by subsequent changes in those signals.

H.5 Boot

- ☐ X0D01 has a 1K pull-up to VDDIOL (Section 8).
- ☐ The device is kept in reset for at least 1 ms after VDDIOL has reached its minimum level (Section 8).

H.6 JTAG, XScope, and debugging

- ☐ You have decided as to whether you need an XSYS header or not (Section G)
- ☐ If you have not included an XSYS header, you have devised a method to program the SPI-flash or OTP (Section G).

H.7 GPIO

- ☐ You have not mapped both inputs and outputs to the same multi-bit port.
- ☐ Pins X0D04, X0D05, X0D06, and X0D07 are output only and are, during and after reset, pulled low or not connected (Section 8)

H.8 Multi device designs

Skip this section if your design only includes a single XMOS device.

- ☐ One device is connected to a QSPI or SPI flash for booting.
- ☐ Devices that boot from link have, for example, X0D06 pulled high and have link XL0 connected to a device to boot from (Section 8).

I PCB Layout Design Check List

☑ This section is a checklist for use by PCB designers using the XS2-UF12A-512-TQ128. Each of the following sections contains items to check for each design.

I.1 Ground Plane

☐ Multiple vias (eg, 9) have been used to connect the center pad to the PCB ground plane. These minimize impedance and conduct heat away from the device. (Section 12.4).

☐ Other than ground vias, there are no (or only a few) vias underneath or closely around the device. This create a good, solid, ground plane.

I.2 Power supply decoupling

☐ The decoupling capacitors are all placed close to a supply pin (Section 12).

☐ The decoupling capacitors are spaced around the device (Section 12).

☐ The ground side of each decoupling capacitor has a direct path back to the center ground of the device.

I.3 PLL_AVDD

☐ The PLL_AVDD filter (especially the capacitor) is placed close to the PLL_AVDD pin (Section 12).